Notice of References Cited Application/Control No. 10/783,940 Examiner DuyVu n. Deo Applicant(s)/Patent Under Reexamination AN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,383,723	05-2002	lyer et al.	430/327
*	В	US-5,637,151	06-1997	Schulz, Peter	134/2
*	С	US-6,159,860	12-2000	Yang et al.	438/706
*	D	US-6,753,247	06-2004	Okoroanyanwu et al.	438/623
*	E	US-6,686,668	02-2004	Nesbit et al.	257/300
*	F	US-5,759,746	06-1998	Azuma et al.	430/313
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-	•		
	L	US- '			
	М	US		·	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Р	9				
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	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	x						

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